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International

International **IOR** Rectifier

IRS233(0,2)(D)(S&J)PbF

June 1 2011 IRS233(0,2)(D)(S & J)PbF

3-PHASE-BRIDGE DRIVER

Features

- Floating channel designed for bootstrap operation Fully operational to +600 V
- Tolerant to negative transient voltage dV/dt immune
- Gate drive supply range from 10 V to 20 V
- Undervoltage lockout for all channels
- Over-current shutdown turns off all six drivers
- Independent half-bridge drivers
- Matched propagation delay for all channels
- 3.3 V logic compatible
- Outputs out of phase with inputs
- Cross-conduction prevention logic
- Integrated Operational Amplifier
- Integrated Bootstrap Diode function (IRS233(0,2)D)
- RoHS Compliant

Description

The IRS233(0,2)(D)(S & J) is a high voltage, high speed power MOSFET and IGBT driver with three independent high and low side referenced output channels. Proprietary HVIC technology enables ruggedized monolithic construction. Logic inputs are compatible with CMOS or LSTTL outputs, down to 3.3 V logic. A ground-referenced operational amplifier provides analog feedback of bridge current via an external current sense resistor. A current trip function which terminates all six outputs is also derived from this resistor. An open drain FAULT signal indicates if an over-current or undervoltage shutdown has occurred. The output drivers feature a high pulse current buffer stage designed for minimum driver cross-conduction. Propagation delays are matched to simplify use at high frequencies. The floating channel can be used to drive N-channel power MOSFET or IGBT in the high side configuration which operates up to 600 volts.

Product Summary

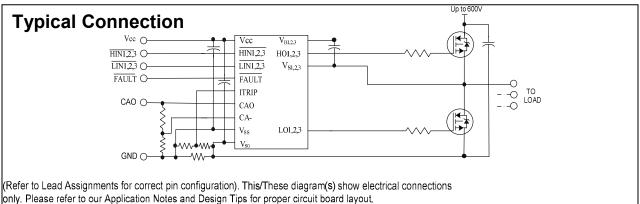
VOFFSET	600V max.
lo+/-	200 mA / 420 mA
Vout	10 V – 20 V (233(0,2)(D))
t _{on/off} (typ.)	500 ns
Deadtime (typ.)	2.0 us (IRS2330(D)) 0.7 us (IRS2332(D))

Applications:

- *Motor Control
- *Air Conditioners/ Washing Machines
- *General Purpose Inverters
- *Micro/Mini Inverter Drives

Packages





International

IRS233(0,2)(D)(S&J)PbF

Qualification Information[†]

			Industrial ^{††}				
Qualification Level		Comments: This family of ICs has passed JEDEC's Industrial qualification. IR's Consumer qualification level is granted by extension of the higher Industrial level.					
Moisturo Sonsitivity Le	vel	SOIC28W	MSL3 ^{†††} , 260°C (per IPC/JEDEC J-STD-020)				
Moisture Sensitivity Level		PLCC44	MSL3 ^{†††} , 245°C (per IPC/JEDEC J-STD-020)				
	Human Body Model	Class 2 (per JEDEC standard JESD22-A114)					
ESD	Machine Model	(per EIA/JEDEC	Class B standard EIA/JESD22-A115)				
IC Latch-Up Test		Class I, Level A (per JESD78)					
RoHS Compliant			Yes				

† Qualification standards can be found at International Rectifier's web site <u>http://www.irf.com/</u>

++ Higher qualification ratings may be available should the user have such requirements. Please contact your International Rectifier sales representative for further information.

⁺⁺⁺ Higher MSL ratings may be available for the specific package types listed here. Please contact your International Rectifier sales representative for further information.

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Absolute Maximum Ratings Absolute Maximum Ratings indicate sustained limits beyond which damage to the device may occur. All voltage parameters are absolute voltages referenced to V_{SO} . The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions.

Symbol	Definition	Min.	Max.	Units	
V _{B1,2,3}	High-side floating supply voltage	-0.3	620		
V _{S1,2,3}	High-side floating offset voltage		V _{B1,2,3} - 20	V _{B1,2,3} + 0.3	
V _{HO1,2,3}	High-side floating output Voltage		V _{S1,2,3} - 0.3	V _{B1,2,3} + 0.3	
V _{CC}	Low-side and logic fixed supply voltage		-0.3	20	
V _{SS}	Logic ground		V _{CC} - 20	V _{CC} + 0.3	
V _{LO1,2,3}	Low-side output voltage		-0.3	V _{CC} + 0.3	v
V _{IN}	Logic input voltage (HIN1,2,3, LIN1,2,3 & IT	.ogic input voltage (HIN1,2,3, LIN1,2,3 & ITRIP)			v
V _{FLT}	FAULT output voltage		V _{SS} -0.3	V _{CC} +0.3	
V _{CAO}	Operational amplifier output voltage		V _{SS} -0.3	V _{CC} +0.3	
V _{CA-}	Operational amplifier inverting input voltage		V _{SS} -0.3	V _{CC} +0.3	
dV _S /dt	Allowable offset supply voltage transient		_	50	V/ns
Pn	Package power dissipation @ TA ≤ +25 °C	(28 lead SOIC)	_	1.6	W
I D		(44 lead PLCC)	_	2.0	•••
Rthua	Thermal resistance, junction to ambient	(28 lead SOIC)	—	78	°C/W
NUIJA	(44 lead PLCC)			63	C/VV
TJ	Junction temperature	—	150		
Τs	Storage temperature		-55	150	°C
TL	Lead temperature (soldering, 10 seconds)		_	300	

International

IRS233(0,2)(D)(S&J)PbF

Recommended Operating Conditions

The Input/Output logic timing diagram is shown in figure 1. For proper operation the device should be used within the recommended conditions. All voltage parameters are absolute voltage referenced to V_{SO} . The V_S offset rating is tested with all supplies biased at 15 V differential.

Symbol	Definition	Min.	Max.	Units
V _{B1,2,3}	High-side floating supply voltage	V _{S1,2,3} +10	V _{S1,2,3} +20	
V _{S1,2,3}	Static high-side floating offset voltage	V _{SO} -8 (Note1)	600	
V _{St1,2,3}	Transient high-side floating offset voltage	-50 (Note2)	600	
V _{HO1,2,3}	High-side floating output voltage	V _{S1,2,3}	V _{B1,2,3}	
Vcc	Low-side and Logic fixed supply voltage	10	20	
V _{SS}	Logic ground	-5	5	V
V _{LO1,2,3}	Low-side output voltage	0	V _{CC}	
V _{IN}	Logic input voltage (HIN1,2,3, LIN1,2,3 & ITRIP)	V _{SS}	V _{SS} + 5	
V_{FLT}	FAULT output voltage	V _{SS}	V _{CC}	
V _{CAO}	Operational amplifier output voltage	V _{SS}	V _{SS} + 5	
V _{CA-}	Operational amplifier inverting input voltage	V _{SS}	V _{SS} + 5	
T _A	Ambient temperature	-40	125	°C

Note 1: Logic operational for V_S of (V_{SO} -8 V) to (V_{SO} +600 V). Logic state held for V_S of (V_{SO} -8 V) to (V_{SO} - V_{BS}). **Note 2:** Operational for transient negative VS of VSS - 50 V with a 50 ns pulse width. Guaranteed by design. Refer to the Application Information section of this datasheet for more details.

Note 3: CAO input pin is internally clamped with a 5.2 V zener diode.

Dynamic Electrical Characteristics

 V_{BIAS} (V_{CC}, $V_{BS1,2,3}$) = 15 V, $V_{SO1,2,3}$ = V_{SS} , C_L = 1000 pF, T_A = 25 °C unless otherwise specified.

Symbol	Definition		Min	Тур	Мах	Units	Test Conditions
t _{on}	Turn-on propagation delay		400	500	700		V _{S1,2,3} = 0 V to 600 V
t _{off}	Turn-off propagation delay			500	700		V S1,2,3 - 0 V to 000 V
tr	Turn-on rise time			80	125		$\lambda = 0 \lambda$
tf	Turn-off fall time	—	35	55		V _{S1,2,3} = 0 V	
t _{itrip}	ITRIP to output shutdown propaga	ition delay	400	660	920		
t _{bl}	ITRIP blanking time			400	_		
t _{flt}	ITRIP to FAULT indication delay			550	870		
t _{flt, in}	Input filter time (all six inputs)			325			
t _{fltclr}	LIN1,2,3 to FAULT clear time (233	80/2)	5300	8500	13700	ns	
DT		(IRS2330(D))	1300	2000	3100		
ы		(IRS2332(D))	500	700	1100		V _{IN} = 0 V & 5 V without
MDT	Deadtime matching: :	(IRS2330(D))		—	400		external deadtime
MDT		(IRS2332(D))	—	—	140		
MT	Delay matching time (t $_{\mbox{ON}}$, t $_{\mbox{OFF}})$		_	_	50		V _{IN} = 0 V & 5 V without external deadtime larger than DT
PM	Pulse width distortion		_	_	75		PM input 10 µs

NOTE: For high side PWM, HIN pulse width must be ≥ 1.5 usec

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Dynamic Electrical Characteristics

 V_{BIAS} (V_{CC}, V_{BS1,2,3}) = 15 V, V_{S01,2,3} = V_{SS} , C_L = 1000 pF, T_A = 25 °C unless otherwise specified.

Symbol	Definition	Min	Тур	Мах	Units	Test Conditions	
SR+	Operational amplifier slew rate (+)	5	10	_		1 V input step	
SR-	Operational amplifier slew rate (-)	2.4	3.2		V/µs	i v input step	

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Static Electrical Characteristics

 V_{BIAS} (V_{CC}, $V_{BS1,2,3}$) = 15 V, $V_{S01,2,3}$ = V_{SS} and T_A = 25 °C unless otherwise specified. The V_{IN} , V_{TH} and I_{IN} parameters are referenced to V_{SS} and are applicable to all six logic input leads: HIN1,2,3 & LIN1,2,3. The V_O and I_O parameters are referenced to $V_{S01,2,3}$ and are applicable to the respective output leads: HO1,2,3 or LO1,2,3.

Symbol	Definition	Min	Тур	Max	Units	Test Conditions
VIH	Logic "0" input voltage (OUT = LO)	_	_	2.2	V	
V _{IL}	Logic "1" input voltage (OUT = HI)	0.8	_	_	v	
V _{IT,TH+}	ITRIP input positive going threshold	400	490	580		
V _{OH}	High level output voltage, V _{BIAS} - V _O	—	_	1000	mV	V_{IN} = 0 V, I_{O} = 20 mA
V _{OL}	Low level output voltage, Vo		_	400		V_{IN} = 5 V, I_{O} = 20 mA
I _{LK}	Offset supply leakage current	_	50		$V_{\rm B} = V_{\rm S} = 600 \ {\rm V}$	
I _{QBS}	Quiescent V _{BS} supply current	_	30	50	μA	V _{IN} = 0 V or 4 V
I _{QCC}	Quiescent V _{CC} supply current		4.0	6.2	mA	V _{IN} = 4 V
I _{IN+}	Logic "1" input bias current (OUT =HI)	-400	-300	-100		V _{IN} = 0 V
I _{IN-}	Logic "0" input bias current (OUT = LO)	-300	-220	-100	μA	V _{IN} = 4 V
I _{ITRIP+}	"High" ITRIP bias current	_	5	10		ITRIP = 4 V
I _{ITRIP-}	"LOW" ITRIP bias current			30	nA	ITRIP = 0 V
V _{BSUV+}	V _{BS} supply undervoltage positive going threshold	7.5	8.35	9.2		
V _{BSUV-}	V _{BS} supply undervoltage negative going threshold	7.1	7.95	8.8		
V _{CCUV+}	V _{CC} supply undervoltage positive going threshold	8.3	9	9.7	V	
V _{CCUV-}	V _{CC} supply undervoltage negative going threshold	8	8.7	9.4		
V _{CCUVH}	Hysteresis	_	0.3			
V _{BSUVH}	Hysteresis		0.4	_		
Ron, FLT	FAULT low on-resistance	_	55	75	Ω	
I _{O+}	Output high short circuit pulsed current		-250	-180	mA	$V_{O} = 0 V, V_{IN} = 0 V$ PW $\leq 10 us$
I _{O-}	Output low short circuit pulsed current	420	500	_		V _O = 15 V, V _{IN} = 5 V PW ≤ 10 us
R _{BS}	Integrated bootstrap diode resistance	—	200		Ω	
Vos	Operational amplifier input offset voltage	—		20	mV	$V_{SO} = 0.2 V$
I _{CA-}	CA- input bias current	—		100	nA	V _{CA-} = 1 V
CMRR	Operational amplifier common mode rejection ratio	—	80	_	dB	V _{SO} = 0.1 V & 5 V
PSRR	Operational amplifier power supply rejection ratio		75	—		V _{SO} = 0.2 V V _{CC} = 9.7 V & 20 V
V _{OH,AMP}	Operational amplifier high level output voltage	4.8	5.2	5.6	V	V _{CA-} = 0 V, V _{SO} =1 V
$V_{OL,AMP}$	Operational amplifier low level output voltage		_	40	mV	V _{CA-} = 1 V, V _{SO} =0 V

Note: The integrated bootstrap diode does not work well with the trapezoidal control.

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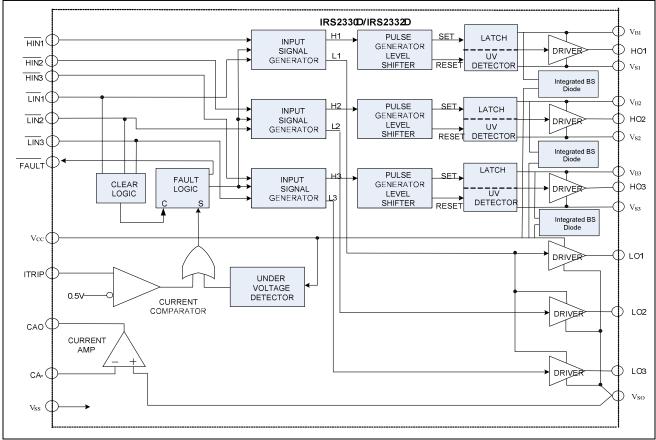
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Static Electrical Characteristics- Continued

 V_{BIAS} (V_{CC}, $V_{BS1,2,3}$) = 15 V, $V_{S01,2,3}$ = V_{SS} and T_A = 25 °C unless otherwise specified. The V_{IN} , V_{TH} and I_{IN} parameters are referenced to V_{SS} and are applicable to all six logic input leads: HIN1,2,3 & LIN1,2,3. The V_O and I_O parameters are referenced to $V_{S01,2,3}$ and are applicable to the respective output leads: HO1,2,3 or LO1,2,3.

Symbol	Definition	Min	Тур	Max	Units	Test Conditions
I _{SRC,AMP}	Operational amplifier output source current	_	-7	-4		$V_{CA-} = 0 V, V_{SO} = 1 V$ $V_{CAO} = 4 V$
I _{SNK,AMP}	Operational amplifier output sink current	1	2.1	_	mA	V _{CA-} = 1 V, V _{SO} =0 V V _{CAO} = 2 V
I _{O+,AMP}	Operational amplifier output high short circuit current	-30	-10	_	ША	$V_{CA-} = 0 V, V_{SO} = 5 V$ $V_{CAO} = 0 V$
I _{O-,AMP}	Operational amplifier output low short circuit current	_	4	_		V _{CA-} = 5 V, V _{SO} =0 V V _{CAO} = 5 V

Functional Block Diagram



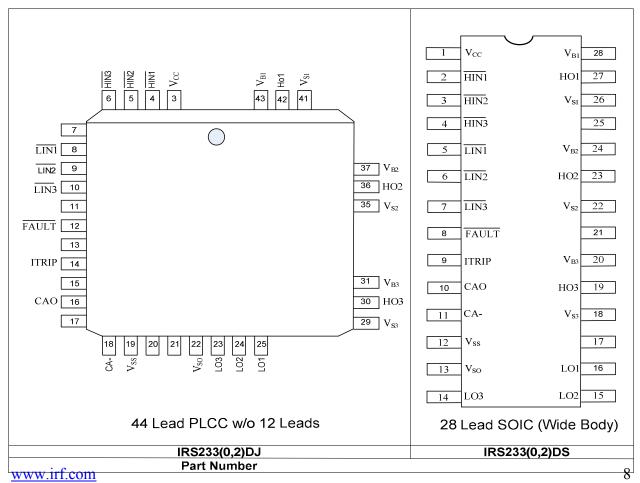
Note: IRS2330 & IRS2332 are without integrated bootstrap diode.

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Lead Definitions

Symbol	Description
HIN1,2,3	Logic input for high-side gate driver outputs (HO1,2,3), out of phase
LIN1,2,3	Logic input for low-side gate driver output (LO1,2,3), out of phase
FAULT	Indicates over-current or undervoltage lockout (low-side) has occurred, negative logic
V _{CC}	Low-side and logic fixed supply
ITRIP	Input for over-current shutdown
CAO	Output of current amplifier
CA-	Negative input of current amplifier
V _{SS}	Logic Ground
V _{B1,2,3}	High-side floating supply
HO1,2,3	High-side gate drive output
V _{S1,2,3}	High-side floating supply return
LO1,2,3	Low-side gate drive output
V _{SO}	Low-side return and positive input of current amplifier

Lead Assignments



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Application Information and Additional Details

Information regarding the following topics are included as subsections within this section of the datasheet.

- IGBT/MOSFET Gate Drive
- Switching and Timing Relationships
- Deadtime
- Matched Propagation Delays
- Input Logic Compatibility
- Undervoltage Lockout Protection
- Shoot-Through Protection
- Fault Reporting
- Over-Current Protection
- Over-Temperature Shutdown Protection
- Truth Table: Undervoltage lockout, ITRIP
- Advanced Input Filter
- Short-Pulse / Noise Rejection
- Integrated Bootstrap Functionality
- Bootstrap Power Supply Design
- Separate Logic and Power Grounds
- Negative V_S Transient SOA
- DC- bus Current Sensing
- PCB Layout Tips
- Integrated Bootstrap FET limitation
- Additional Documentation

IGBT/MOSFET Gate Drive

The IRS233(2,0)(D) HVICs are designed to drive up to six MOSFET or IGBT power devices. Figures 1 and 2 illustrate several parameters associated with the gate drive functionality of the HVIC. The output current of the HVIC, used to drive the gate of the power switch, is defined as I_0 . The voltage that drives the gate of the external power switch is defined as V_{HO} for the high-side power switch; this parameter is sometimes generically called V_{OUT} and in this case does not differentiate between the high-side or low-side output voltage.

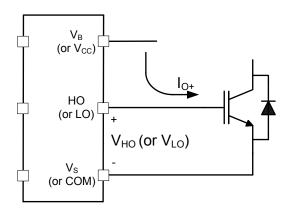


Figure 1: HVIC sourcing current

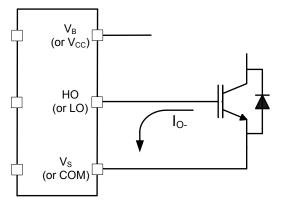


Figure 2: HVIC sinking current

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Switching and Timing Relationships

The relationship between the input and output signals of the IRS233(0,2)(D) are illustrated below in Figures 3. From these figures, we can see the definitions of several timing parameters (i.e., PW_{IN} , PW_{OUT} , t_{ON} , t_{OFF} , t_R , and t_F) associated with this device.

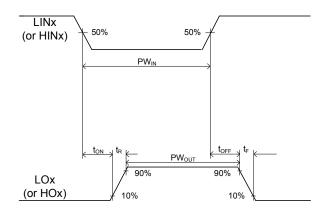


Figure 3: Switching time waveforms

The following two figures illustrate the timing relationships of some of the functionality of the IRS233(0,2)(D); this functionality is described in further detail later in this document.

During interval A of Figure 4, the HVIC has received the command to turn-on both the high- and low-side switches at the same time; as a result, the shoot-through protection of the HVIC has prevented this condition and both the high- and low-side output are held in the off state.

Interval B of Figures 4 shows that the signal on the ITRIP input pin has gone from a low to a high state; as a result, all of the gate drive outputs have been disabled (i.e., see that HOx has returned to the low state; LOx is also held low) and a fault is reported by the FAULT output transitioning to the low state. Once the ITRIP input has returned to the low state, the fault condition is latched until the all LINx become high.

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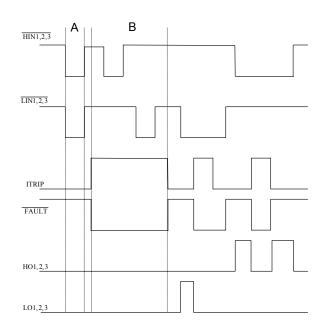


Figure 4: Input/output timing diagram

Deadtime

This family of HVICs features integrated deadtime protection circuitry. The deadtime for these ICs is fixed; other ICs within IR's HVIC portfolio feature programmable deadtime for greater design flexibility. The deadtime feature inserts a time period (a minimum deadtime) in which both the high- and low-side power switches are held off; this is done to ensure that the power switch being turned off has fully turned off before the second power switch is turned on. This minimum deadtime is automatically inserted whenever the external deadtime is shorter than DT; external deadtimes larger than DT are not modified by the gate driver. Figure 5 illustrates the deadtime period and the relationship between the output gate signals.

The deadtime circuitry of the IRS233(0,2)(D) is matched with respect to the high- and low-side outputs of a given channel; additionally, the deadtimes of each of the three channels are matched.

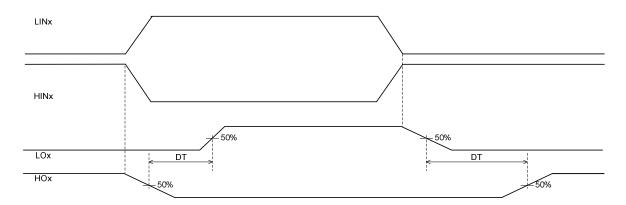


Figure 5: Illustration of deadtime

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Matched Propagation Delays

The IRS233(0,2)(D) family of HVICs is designed with propagation delay matching circuitry. With this feature, the IC's response at the output to a signal at the input requires approximately the same time duration (i.e., t_{ON} , t_{OFF}) for both the low-side channels and the high-side channels. Additionally, the propagation delay for each low-side channel is matched when compared to the other low-side channels and the propagation delays of the high-side channels are matched with each other. The propagation turn-on delay (t_{ON}) of the IRS233(0,2)(D) is matched to the propagation turn-on delay (t_{OFF}).

Input Logic Compatibility

The inputs of this IC are compatible with standard CMOS and TTL outputs. The IRS233(0,2)(D) family has been designed to be compatible with 3.3 V and 5 V logic-level signals. The IRS233(0,2)(D) features an integrated 5.2 V Zener clamp on the HIN, LIN, and ITRIP pins. Figure 6 illustrates an input signal to the IRS233(0,2)(D), its input threshold values, and the logic state of the IC as a result of the input signal.

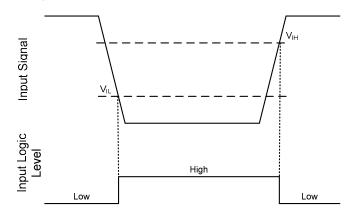


Figure 6: HIN & LIN input thresholds

Undervoltage Lockout Protection

This family of ICs provides undervoltage lockout protection on both the V_{CC} (logic and low-side circuitry) power supply and the V_{BS} (high-side circuitry) power supply. Figure 7 is used to illustrate this concept; V_{CC} (or V_{BS}) is plotted over time and as the waveform crosses the UVLO threshold ($V_{CCUV+/-}$ or $V_{BSUV+/-}$) the undervoltage protection is enabled or disabled.

Upon power-up, should the V_{CC} voltage fail to reach the V_{CCUV+} threshold, the IC will not turn-on. Additionally, if the V_{CC} voltage decreases below the V_{CCUV-} threshold during operation, the undervoltage lockout circuitry will recognize a fault condition and shutdown the high- and low-side gate drive outputs, and the FAULT pin will transition to the low state to inform the controller of the fault condition.

Upon power-up, should the V_{BS} voltage fail to reach the V_{BSUV} threshold, the IC will not turn-on. Additionally, if the V_{BS} voltage decreases below the V_{BSUV} threshold during operation, the undervoltage lockout circuitry will recognize a fault condition, and shutdown the high-side gate drive outputs of the IC.

The UVLO protection ensures that the IC drives the external power devices only when the gate supply voltage is sufficient to fully enhance the power devices. Without this feature, the gates of the external power switch could be driven with a low voltage, resulting in the power switch conducting current while the channel impedance is high; this could result in very high conduction losses within the power device and could lead to power device failure.

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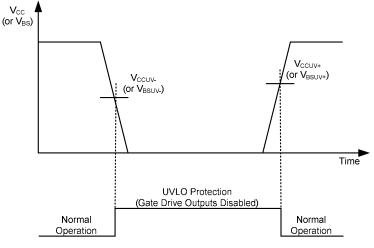
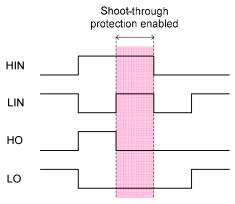


Figure 7: UVLO protection

Shoot-Through Protection

The IRS233(0,2)(D) family of high-voltage ICs is equipped with shoot-through protection circuitry (also known as crossconduction prevention circuitry). Figure 8 shows how this protection circuitry prevents both the high- and low-side switches from conducting at the same time. Table 1 illustrates the input/output relationship of the devices in the form of a truth table. Note that the IRS233(0,2)(D) has inverting inputs (the output is out-of-phase with its respective input).





IRS233(0,2)(D)							
HIN LIN HO LO							
0	0	0	0				
0	1	1	0				
1	0	0	1				
1	1	0	0				

Table 1: Input/output truth table

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Fault Reporting

The IRS233(0,2)(D) family provides an integrated fault reporting output. There are two situations that would cause the HVIC to report a fault via the FAULT pin. The first is an undervoltage condition of V_{CC} and the second is if the ITRIP pin recognizes a fault. Once the fault condition occurs, the FAULT pin is internally pulled to V_{SS} and the fault condition is latched. The fault output stays in the low state until the fault condition has been removed by all LINx set to high state. Once the fault is removed, the voltage on the FAULT pin will return to V_{CC} .

Over-Current Protection

The IRS233(0,2)(D) HVICs are equipped with an ITRIP input pin. This functionality can be used to detect over-current events in the DC- bus. Once the HVIC detects an over-current event through the ITRIP pin, the outputs are shutdown, a fault is reported through the FAULT pin.

The level of current at which the over-current protection is initiated is determined by the resistor network (i.e., R_0 , R_1 , and R_2) connected to ITRIP as shown in Figure 9, and the ITRIP threshold ($V_{IT,TH+}$). The circuit designer will need to determine the maximum allowable level of current in the DC- bus and select R_0 , R_1 , and R_2 such that the voltage at node V_X reaches the over-current threshold ($V_{IT,TH+}$) at that current level.

 $V_{IT TH+} = R_0 I_{DC-} (R_1 / (R_1 + R_2))$

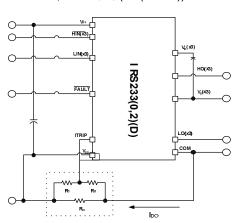


Figure 9: Programming the over-current protection

For example, a typical value for resistor R_0 could be 50 m Ω . The voltage of the ITRIP pin should not be allowed to exceed 5 V; if necessary, an external voltage clamp may be used.

Over-Temperature Shutdown Protection

The ITRIP input of the IRS233(0,2)(D) can also be used to detect over-temperature events in the system and initiate a shutdown of the HVIC (and power switches) at that time. In order to use this functionality, the circuit designer will need to design the resistor network as shown in Figure 10 and select the maximum allowable temperature.

This network consists of a thermistor and two standard resistors R₃ and R₄. As the temperature changes, the resistance of the thermistor will change; this will result in a change of voltage at node V_X. The resistor values should be selected such the voltage V_X should reach the threshold voltage (V_{IT,TH+}) of the ITRIP functionality by the time that the maximum allowable temperature is reached. The voltage of the ITRIP pin should not be allowed to exceed 5 V.

When using both the over-current protection and over-temperature protection with the ITRIP input, OR-ing diodes (e.g., DL4148) can be used. This network is shown in Figure 11; the OR-ing diodes have been labeled D_1 and D_2 .

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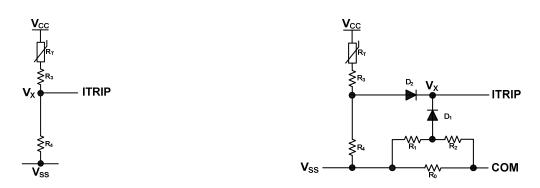


Figure 10: Programming over-temperature protection Figure 11: Using over-current protection and over-temperature protection

Truth Table: Undervoltage lockout and ITRIP

Table 2 provides the truth table for the IRS233(0,2)(D). The first line shows that the UVLO for V_{CC} has been tripped; the FAULT output has gone low and the gate drive outputs have been disabled. V_{CCUV} is not latched in this case and when V_{CC} is greater than V_{CCUV} , the FAULT output returns to the high impedance state.

The second case shows that the UVLO for V_{BS} has been tripped and that the high-side gate drive outputs have been disabled. After V_{BS} exceeds the V_{BSUV} threshold, HO will stay low until the HVIC input receives a new falling transition of HIN. The third case shows the normal operation of the HVIC. The fourth case illustrates that the ITRIP trip threshold has been reached and that the gate drive outputs have been disabled and a fault has been reported through the fault pin. The fault output stays in the low state until the fault condition has been removed by all LINx set to high state. Once the fault is removed, the voltage on the FAULT pin will return to V_{CC} .

	VCC	VBS	ITRIP	FAULT	LO	НО
UVLO V _{cc}	<v<sub>CCUV</v<sub>			0	0	0
UVLO V _{BS}	15 V	<v<sub>BSUV</v<sub>	0 V	High impedance	LIN	0
Normal operation	15 V	15 V	0 V	High impedance	LIN	HIN
ITRIP fault	15 V	15 V	>V _{ITRIP}	0	0	0

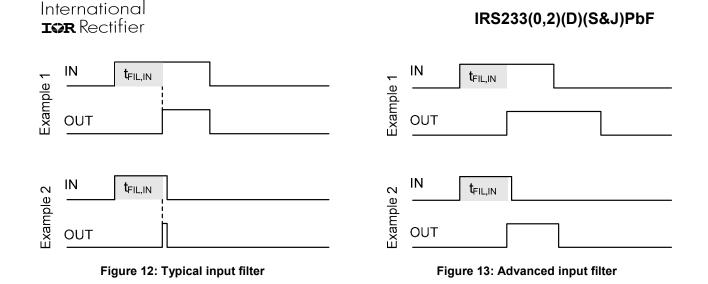
Table 2: IRS233(0,2)(D) UVLO, ITRIP & FAULT truth table

Advanced Input Filter

The advanced input filter allows an improvement in the input/output pulse symmetry of the HVIC and helps to reject noise spikes and short pulses. This input filter has been applied to the HIN and LIN. The working principle of the new filter is shown in Figures 12 and 13.

Figure 12 shows a typical input filter and the asymmetry of the input and output. The upper pair of waveforms (Example 1) show an input signal with a duration much longer than $t_{FIL,IN}$; the resulting output is approximately the difference between the input signal and $t_{FIL,IN}$. The lower pair of waveforms (Example 2) show an input signal with a duration slightly longer then $t_{FIL,IN}$; the resulting output is approximately the difference between the input signal and $t_{FIL,IN}$.

Figure 13 shows the advanced input filter and the symmetry between the input and output. The upper pair of waveforms (Example 1) show an input signal with a duration much longer then $t_{FIL,IN}$; the resulting output is approximately the same duration as the input signal. The lower pair of waveforms (Example 2) show an input signal with a duration slightly longer then $t_{FIL,IN}$; the resulting output is approximately the same duration as the input signal with a duration slightly longer then $t_{FIL,IN}$; the resulting output is approximately the same duration as the input signal.



Short-Pulse / Noise Rejection

This device's input filter provides protection against short-pulses (e.g., noise) on the input lines. If the duration of the input signal is less than $t_{FIL,IN}$, the output will not change states. Example 1 of Figure 14 shows the input and output in the low state with positive noise spikes of durations less than $t_{FIL,IN}$; the output does not change states. Example 2 of Figure 19 shows the input and output in the high state with negative noise spikes of durations less than $t_{FIL,IN}$; the output does not change states.

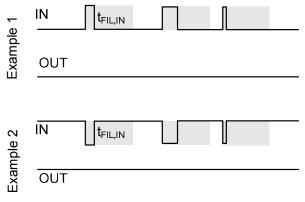


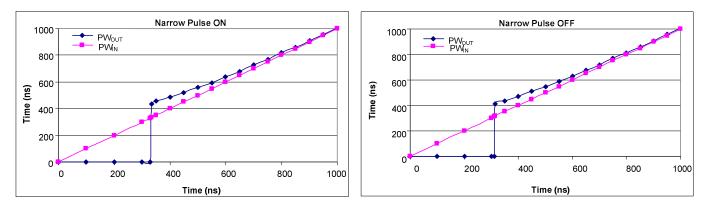
Figure 14: Noise rejecting input filters

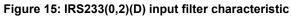
Figures 15 and 16 present lab data that illustrates the characteristics of the input filters while receiving ON and OFF pulses.

The input filter characteristic is shown in Figure 15; the left side illustrates the narrow pulse ON (short positive pulse) characteristic while the left shows the narrow pulse OFF (short negative pulse) characteristic. The x-axis of Figure 20 shows the duration of PW_{IN} , while the y-axis shows the resulting PW_{OUT} duration. It can be seen that for a PW_{IN} duration less than $t_{FIL,IN}$, that the resulting PW_{OUT} duration is zero (e.g., the filter rejects the input signal/noise). We also see that once the PW_{IN} duration exceed $t_{FIL,IN}$, that the PW_{OUT} durations mimic the PW_{IN} durations very well over this interval with the symmetry improving as the duration increases. To ensure proper operation of the HVIC, it is suggested that the input pulse width for the high-side inputs be ≥ 500 ns.

The difference between the PW_{OUT} and PW_{IN} signals of both the narrow ON and narrow OFF cases is shown in Figure 16; the careful reader will note the scale of the y-axis. The x-axis of Figure 21 shows the duration of PW_{IN} , while the y-axis shows the resulting PW_{OUT} – PW_{IN} duration. This data illustrates the performance and near symmetry of this input filter.

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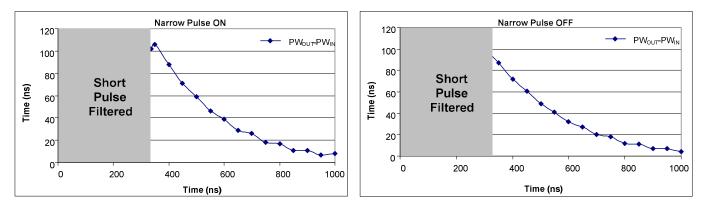


Figure 16: Difference between the input pulse and the output pulse

Integrated Bootstrap Functionality

The new IRS233(0,2)D family features integrated high-voltage bootstrap MOSFETs that eliminate the need of the external bootstrap diodes and resistors in many applications.

There is one bootstrap MOSFET for each high-side output channel and it is connected between the V_{CC} supply and its respective floating supply (i.e., V_{B1} , V_{B2} , V_{B3}); see Figure 17 for an illustration of this internal connection.

The integrated bootstrap MOSFET is turned on only during the time when LO is 'high', and it has a limited source current due to R_{BS} . The V_{BS} voltage will be charged each cycle depending on the on-time of LO and the value of the C_{BS} capacitor, the drain-source (collector-emitter) drop of the external IGBT (or MOSFET), and the low-side free-wheeling diode drop.

The bootstrap MOSFET of each channel follows the state of the respective low-side output stage (i.e., the bootstrap MOSFET is ON when LO is high, it is OFF when LO is low), unless the V_B voltage is higher than approximately 110% of V_{CC} . In that case, the bootstrap MOSFET is designed to remain off until V_B returns below that threshold; this concept is illustrated in Figure 18.

International IRS233(0,2)(D)(S&J)PbF **IOR** Rectifier V_{B1} Bootstrap MOSFET V_{cc} VBS disabled V...~ 1 10V-Vcc=15) V_{B2} Time LO Bootstrap V_{B3} MOSFET OFF ON ΟN state

Figure 17: Internal bootstrap MOSFET connection



A bootstrap MOSFET is suitable for most of the PWM modulation schemes and can be used either in parallel with the external bootstrap network (i.e., diode and resistor) or as a replacement of it. The use of the integrated bootstrap as a replacement of the external bootstrap network may have some limitations. An example of this limitation may arise when this functionality is used in non-complementary PWM schemes (typically 6-step modulations) and at very high PWM duty cycle. In these cases, superior performances can be achieved by using an external bootstrap diode in parallel with the internal bootstrap network.

Bootstrap Power Supply Design

For information related to the design of the bootstrap power supply while using the integrated bootstrap functionality of the IRS233(0,2)D family, please refer to Application Note 1123 (AN-1123) entitled "Bootstrap Network Analysis: Focusing on the Integrated Bootstrap Functionality." This application note is available at <u>www.irf.com</u>.

For information related to the design of a standard bootstrap power supply (i.e., using an external discrete diode) please refer to Design Tip 04-4 (DT04-4) entitled "Using Monolithic High Voltage Gate Drivers." This design tip is available at <u>www.irf.com</u>.

Separate Logic and Power Grounds

The IRS233(0,2)(D) has separate logic and power ground pin (V_{SS} and VSO respectively) to eliminate some of the noise problems that can occur in power conversion applications. Current sensing shunts are commonly used in many applications for power inverter protection (i.e., over-current protection), and in the case of motor drive applications, for motor current measurements. In these situations, it is often beneficial to separate the logic and power grounds.

Figure 19 shows a HVIC with separate V_{SS} and VSO pins and how these two grounds are used in the system. The V_{SS} is used as the reference point for the logic and over-current circuitry; V_X in the figure is the voltage between the ITRIP pin and the V_{SS} pin. Alternatively, the VSO pin is the reference point for the low-side gate drive circuitry. The output voltage used to drive the low-side gate is V_{LO} -VSO; the gate-emitter voltage (V_{GE}) of the low-side switch is the output voltage of the driver minus the drop across $R_{G,LO}$.

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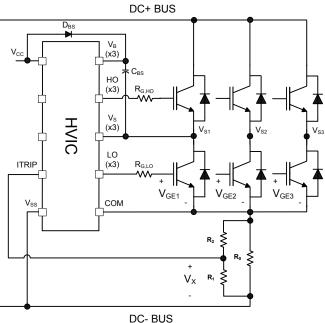
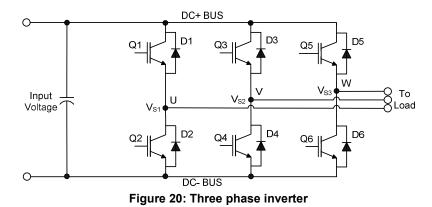


Figure 19: Separate V_{SS} and VSO pins

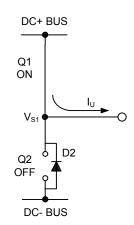
Negative V_S Transient SOA

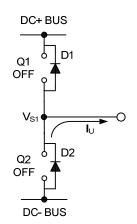
A common problem in today's high-power switching converters is the transient response of the switch node's voltage as the power switches transition on and off quickly while carrying a large current. A typical 3-phase inverter circuit is shown in Figure 20; here we define the power switches and diodes of the inverter.

If the high-side switch (e.g., the IGBT Q1 in Figures 21 and 22) switches off, while the U phase current is flowing to an inductive load, a current commutation occurs from high-side switch (Q1) to the diode (D2) in parallel with the low-side switch of the same inverter leg. At the same instance, the voltage node V_{S1} , swings from the positive DC bus voltage to the negative DC bus voltage.



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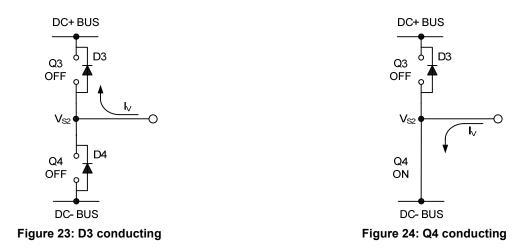


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Figure 21: Q1 conducting

Figure 22: D2 conducting

Also when the V phase current flows from the inductive load back to the inverter (see Figures 23 and 24), and Q4 IGBT switches on, the current commutation occurs from D3 to Q4. At the same instance, the voltage node, V_{S2} , swings from the positive DC bus voltage to the negative DC bus voltage.

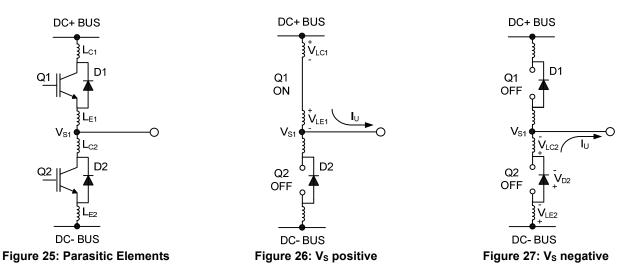


However, in a real inverter circuit, the V_S voltage swing does not stop at the level of the negative DC bus, rather it swings below the level of the negative DC bus. This undershoot voltage is called "negative V_S transient".

The circuit shown in Figure 25 depicts one leg of the three phase inverter; Figures 26 and 27 show a simplified illustration of the commutation of the current between Q1 and D2. The parasitic inductances in the power circuit from the die bonding to the PCB tracks are lumped together in L_C and L_E for each IGBT. When the high-side switch is on, V_{S1} is below the DC+ voltage by the voltage drops associated with the power switch and the parasitic elements of the circuit. When the high-side power switch turns off, the load current momentarily flows in the low-side freewheeling diode due to the inductive load connected to V_{S1} (the load is not shown in these figures). This current flows from the DC- bus (which is connected to the VSO pin of the HVIC) to the load and a negative voltage between V_{S1} and the DC- Bus is induced (i.e., the VSO pin of the HVIC is at a higher potential than the V_S pin).

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In a typical motor drive system, dV/dt is typically designed to be in the range of 3-5 V/ns. The negative V_S transient voltage can exceed this range during some events such as short circuit and over-current shutdown, when di/dt is greater than in normal operation.

International Rectifier's HVICs have been designed for the robustness required in many of today's demanding applications. An indication of the IRS233(0,2)(D)'s robustness can be seen in Figure 28, where there is represented the IRS233(0,2)(D) Safe Operating Area at V_{BS} =15V based on repetitive negative V_S spikes. A negative V_S transient voltage falling in the grey area (outside SOA) may lead to IC permanent damage; viceversa unwanted functional anomalies or permanent damage to the IC do not appear if negative Vs transients fall inside SOA.

At V_{BS} =15V in case of -V_S transients greater than -16.5 V for a period of time greater than 50 ns; the HVIC will hold by design the high-side outputs in the off state for 4.5 µs.

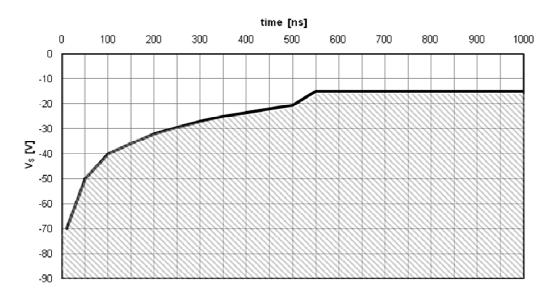


Figure 28: Negative V_S transient SOA for IRS233(0,2)(D)

Even though the IRS233(0,2)(D) has been shown able to handle these large negative V_S transient conditions, it is highly recommended that the circuit designer always limit the negative V_S transients as much as possible by careful PCB layout and component use.

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DC- bus Current Sensing

A ground referenced current signal amplifier has been included so that the current in the return leg of the DC bus may be monitored. A typical circuit configuration is provided in Fig.29. The signal coming from the shunt resistor is amplified by the ratio (R1+R2)/R2. Additional details can be found on Design Tip DT 92-6. This design tip is available at <u>www.irf.com</u>.

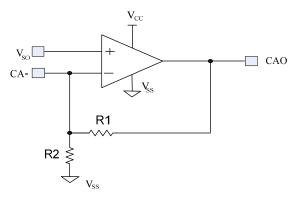


Figure 29: Current amplifier typical configuration

In the following Figures 30, 31, 32, 33 the configurations used to measure the operational amplifier characteristics are shown.

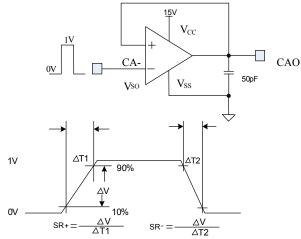


Figure 30: Operational Amplifier Slew rate measurement

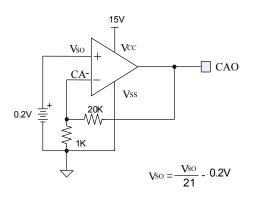
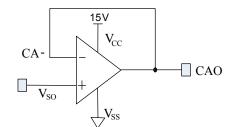


Figure 31: Operational Amplifier Input Offset Voltage measurement

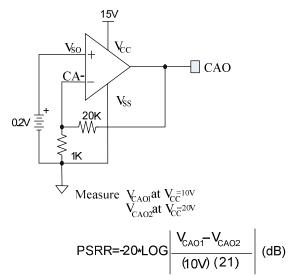
International **IGR** Rectifier

CMRR=-20*LOG



 $\begin{array}{c} \text{Measure} \quad V_{\text{CAO1}} \text{ at } V_{\text{SO}} = 0.1 V \\ V_{\text{CAO2}} \text{ at } V_{\text{SO}} = 1.1 V \end{array}$ $\left| \frac{(V_{CAO1} - 0.1V) - (V_{CAO2} - 1.1V)}{(dB)} \right|$





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Figure 33: Operational Amplifier Power supply rejection measurement

PCB Layout Tips

Distance between high and low voltage components: It's strongly recommended to place the components tied to the floating voltage pins (V_B and V_S) near the respective high voltage portions of the device. The IRS233(0,2)(D) in the PLCC44 package has had some unused pins removed in order to maximize the distance between the high voltage and low voltage pins. Please see the Case Outline PLCC44 information in this datasheet for the details.

Ground Plane: In order to minimize noise coupling, the ground plane should not be placed under or near the high voltage floating side.

Gate Drive Loops: Current loops behave like antennas and are able to receive and transmit EM noise (see Figure 34). In order to reduce the EM coupling and improve the power switch turn on/off performance, the gate drive loops must be reduced as much as possible. Moreover, current can be injected inside the gate drive loop via the IGBT collector-to-gate parasitic capacitance. The parasitic auto-inductance of the gate loop contributes to developing a voltage across the gate-emitter, thus increasing the possibility of a self turn-on effect.

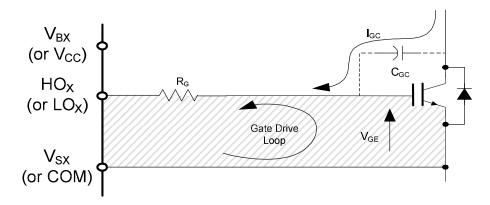


Figure 34: Antenna Loops

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<u>Supply Capacitor:</u> It is recommended to place a bypass capacitor (C_{IN}) between the V_{CC} and V_{SS} pins. This connection is shown in Figure 35. A ceramic 1 μ F ceramic capacitor is suitable for most applications. This component should be placed as close as possible to the pins in order to reduce parasitic elements.

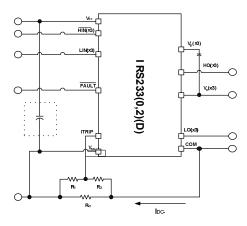
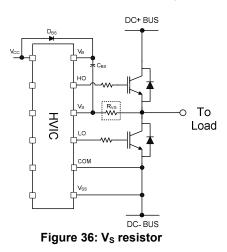


Figure 35: Supply capacitor

Routing and Placement: Power stage PCB parasitic elements can contribute to large negative voltage transients at the switch node; it is recommended to limit the phase voltage negative transients. In order to avoid such conditions, it is recommended to 1) minimize the high-side emitter to low-side collector distance, and 2) minimize the low-side emitter to negative bus rail stray inductance. However, where negative V_S spikes remain excessive, further steps may be taken to reduce the spike. This includes placing a resistor (5 Ω or less) between the V_S pin and the switch node (see Figure 36), and in some cases using a clamping diode between V_{SS} and V_S (see Figure 37). See DT04-4 at www.irf.com for more detailed information.



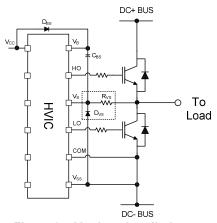


Figure 37: V_S clamping diode

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Integrated Bootstrap FET limitation

The integrated Bootstrap FET functionality has an operational limitation under the following bias conditions applied to the HVIC:

- VCC pin voltage = 0V AND
- VS or VB pin voltage > 0

In the absence of a VCC bias, the integrated bootstrap FET voltage blocking capability is compromised and a current conduction path is created between VCC & VB pins, as illustrated in Fig.38 below, resulting in power loss and possible damage to the HVIC.

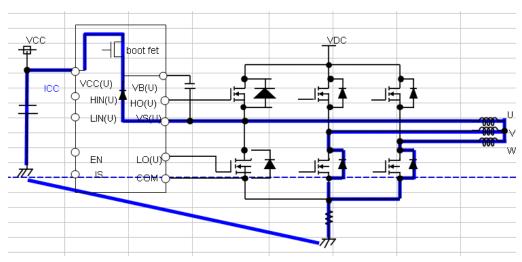


Figure 38: Current conduction path between VCC and VB pin

Relevant Application Situations:

The above mentioned bias condition may be encountered under the following situations:

- In a motor control application, a permanent magnet motor naturally rotating while VCC power is OFF. In this
 condition, Back EMF is generated at a motor terminal which causes high voltage bias on VS nodes resulting
 unwanted current flow to VCC.
- Potential situations in other applications where VS/VB node voltage potential increases before the VCC voltage is available (for example due to sequencing delays in SMPS supplying VCC bias)

Application Workaround:

Insertion of a standard p-n junction diode between VCC pin of IC and positive terminal of VCC capacitors (as illustrated in Fig.39) prevents current conduction "out-of" VCC pin of gate driver IC. It is important not to connect the VCC capacitor directly to pin of IC. Diode selection is based on 25V rating or above & current capability aligned to ICC consumption of IC - 100mA should cover most application situations. As an example, Part number # LL4154 from Diodes Inc (25V/150mA standard diode) can be used.